

Search Notes

Application/Control No.

10/645,789

Examiner

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Applicant(s)/Patent under
Reexamination

MOHANTY ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	5	2/16/2006	JSL
716	4	2/16/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	2/16/2006	JSL
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	3/2/2006	JSL